Notice of References Cited	Application/Control No. 10/509,738	Applicant(s)/Patent Under Reexamination KIYAMA ET AL.	
	Examiner Sean E. Aeder, Ph.D.	Art Unit 1642	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,783,961 B1	08-2004	Edwards et al.	435/91.1
	B	US-			
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	D	US-			
	E	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*	U	Nagase et al (DNA Research, 1996, 3:43-53)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.